Search Notes	

Application/Control No.	Applicant(s)/Patent under Reexamination
10/750,368	LUCK ET AL.
Examiner	Art Unit
Binh V. Ho	2163

	SEAR	CHED	
Class	Subclass	Date	Examiner
707	3	7/8/2006	вн
			-

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
707/3,100-102,203 East search (see printout)	7/8/2006	вн	
Consulted Hung Pham	7/5/2006	вн	
	i		